# **Amplifiers in systems**

## • Amplification

- single gain stage rarely sufficient
- add gain to avoid external noise eg to transfer signals from detector
- practical designs depend on detailed requirements
  - constraints on power, space,... cost in large systems
- e.g. ICs use limited supply voltage which may constrain dynamic range
- •Noise will be an important issue in many situations most noise originates at input as first stage of amplifier dominates often refer to Preamplifier = input amplifier may be closest to sensor, subsequently transfer signal further away
- •In principle, several possible choices
  - V sensitive
  - I sensitive
  - Q sensitive

# **Voltage sensitive amplifier**

•As we have seen many sensors produce current signals but some examples produce voltages - thermistor, thermocouple,...

op-amp voltage amplifier ideal for these

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especially slowly varying signals - few kHz or less
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•For sensors with current signals voltage amplifier usually used for secondary stages of amplification

C<sub>det</sub> •Signal  $V_{out} = Q_{sig}/C_{tot}$ C<sub>tot</sub> = total input capacitance VO  $C_{tot}$  will also include contributions from wiring and amplifier V<sub>out</sub> depends on C<sub>tot</sub> not desirable if C<sub>det</sub> is likely to vary eg with time, between similar sensors, or depending on conditions to be discussed more later •Noise contribution from amplifier, and possibly sensor  $S/N = Q_{sig}/(C_{tot}.v_{noise})$ can it be optimised? 2 November 20, 2001

# **Current sensitive amplifier**

•Common configuration, eg for photodiode signals

$$v_{out} = -Av_{in}$$
  

$$v_{in} - v_{out} = i_{in}R_{f}$$
  

$$v_{out} = -[A/(A+1)].i_{in}R_{f} - i_{in}R_{f}$$

•Input impedance

 $v_{in} = i_{in}R_f/(A+1)$   $Z_{in} = R_f/(A+1)$ 

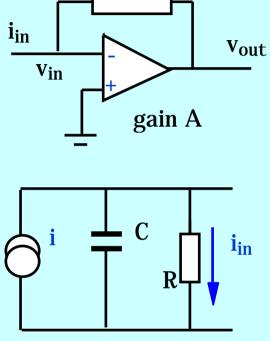
•Effect of C &  $R_{in}$  - consider in frequency domain  $v_0 = i(1/j \ C | |R_{in})$ = i()R/(1+j)

input signal convoluted with falling exponential increasing  $R_f$  to gain sensitivity will increase fast pulses will follow input with some broadening

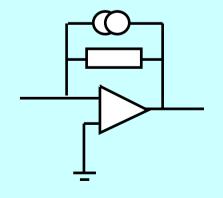
#### •Noise

will later find that feedback resistor is a noise source contributes current fluctuations at input  $\sim 1/R_{\rm f}$ 

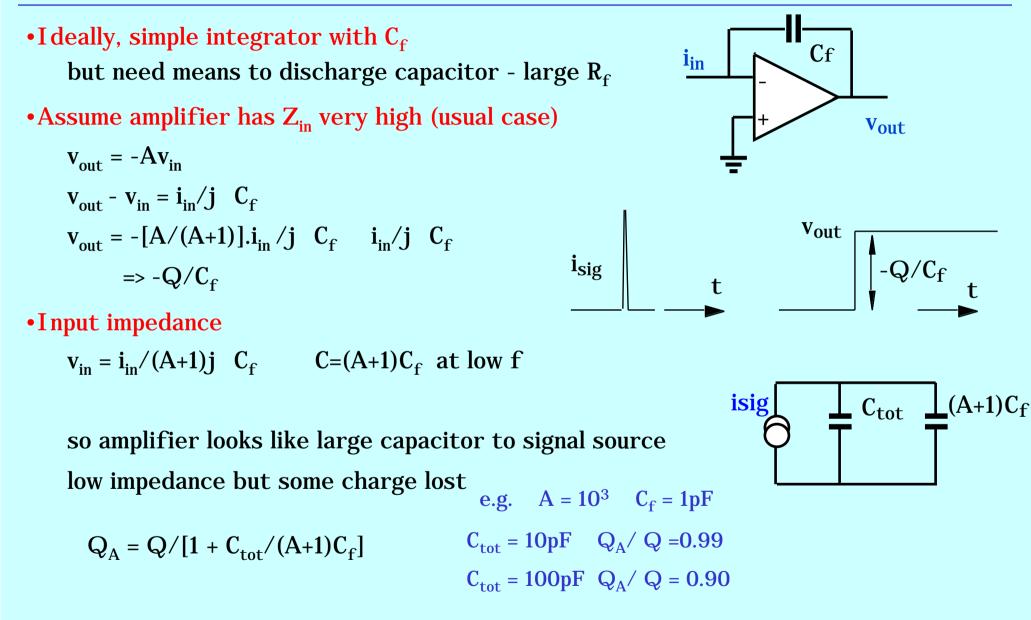
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R<sub>f</sub>



# **Charge sensitive amplifier**

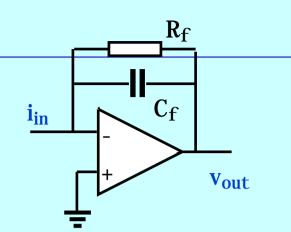


# **Feedback resistance**

•Must have means to discharge capacitor so add  $R_{\rm f}$ 

$$Z_{f} = R_{f} ||1/j C_{f}$$
$$v_{out} = -[A/(A+1)].i_{in}Z_{f}$$

$$= i()R_{f}/(1+j_{f})$$
  $f = R_{f}C_{f}$ 



 $\begin{array}{ll} \mbox{step replaced by decay with $\sim$ exp(-t/R_fC_f)$ is long because $R_f$ is large (noise)$ easiest way to limit pulse pileup - differentiate$ ie add high pass filter$ \\ \end{array}$ 

### •Pole-zero cancellation

exponential decay + differentiation => unwanted baseline undershoot

introduce canceling network

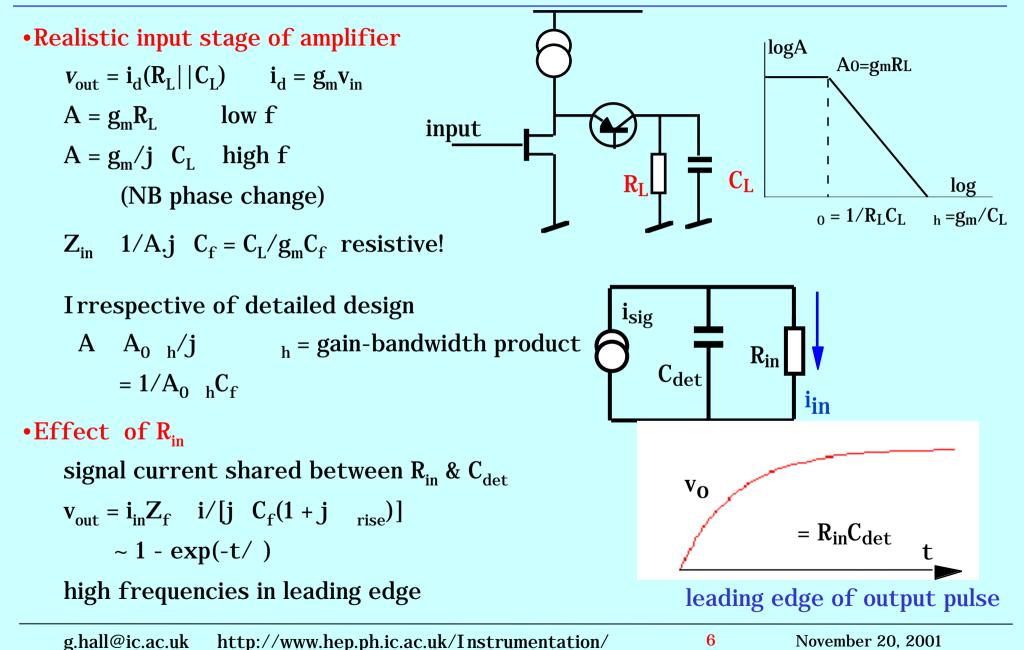
$$v_0 = 1/(1 + j_f)$$
  
 $v_1 = 1/(1 + j_f)(1 + j_1)$   
 $_1 = RC < f_f$   
add resistor  $R_p$  so  $R_pC = f_f$   
then  
 $v_1' = 1/(1 + j_3)$  with  $_3 = (R | |R_p)C < f_f$ 

R<sub>f</sub> C<sub>f</sub> C C

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# **Effect of finite bandwidth**



# **Output impedance**

-Usual method of varying  $v_{\mbox{\scriptsize out}}$  and finding  $i_{\mbox{\scriptsize out}}$  - generally messy algebra

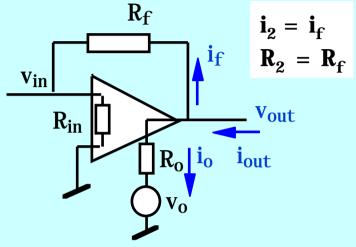
•Current sensitive amplifier, open loop gain = A

$$v_{out} = i_2(R_2 + R_{in})$$
  

$$v_{in} = i_2R_{in}$$
  

$$v_o = -Av_{in} = -Ai_2R_{in}$$
  

$$i_o = (v_{out} - v_0)/R_o = (v_{out} - Ai_2R_{in})/R_o$$



$$\begin{aligned} Z_{out} &= v_{out} / i_{out} = R_o \, (R_2 + R_{in}) / [Ro + R_2 + R_{in}(A+1)] \\ R_o / (A+1) \\ since \, R_{in} >> R_2, \, R_o \end{aligned}$$

R<sub>o</sub> = open loop output impedance

### •In general

 $Z_{out} = R_o/(1+Ab)$  if <u>voltage</u> is sampled at output b = feedback fraction  $Z_{out} = R_o(1+Ab)$  if <u>current</u> is sampled at output

# **Comparators**

•Frequently need to compare a signal with a reference

eg temperature control, light detection, DVM,... basis of analogue to digital conversion -> 1 bit

### •Comparator

high gain differential amplifier,

difference between inputs sends output to saturation (+ or -)

could be op-amp - without feedback - or purpose designed IC  $% \mathcal{A}$ 

Sometimes ICs designed with open-collector output so add pull-up R to supply also available with latch (memory) function

## •NB

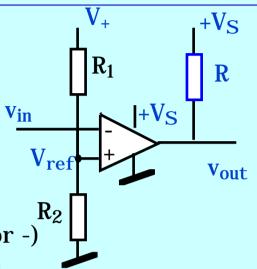
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no negative feedback so v_{\scriptscriptstyle -} - v_{\scriptscriptstyle +}
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saturation voltages may not reach supply voltages - check specs speed of transition

### •Potential problem

multiple transitions as signal changes near threshold

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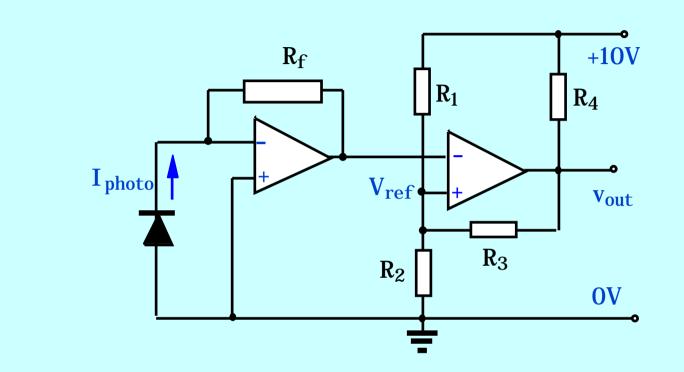
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## Hysteresis

•Add positive feedback (Schmitt trigger) ۲Vs  $V_{ref}$  changes as  $v_{out} \rightarrow +V_S$ Rı ie threshold falls once transition is made Vin  $+V_{S}$ preventing immediate fall Vref positive feedback speeds transition Vout  $v_{out} = A(V_{ref} - v)$  $R_3$  $R_2$  $V_{ref} > v_{-} \implies v_{out} = V_s \quad V_{ref} = V_{high}$  $V_{ref} < v_{-} \Rightarrow v_{out} = 0V V_{ref} = V_{low}$ here, signal => logical "1":  $v_{out} = 0V$ •Output depends on history  $eg V_{\perp} = 10V, V_{S} = +5V, 0V$  $R_1 = 10k$  ,  $R_2 = 10k$  ,  $R_3 = 100k$  $+V_{S}$  $V_{out} = 0V, V_{ref} = 4.76V$ **0**V  $V_{out} = 5V, V_{ref} = 5V$ hysteresis =  $V_{ref} = 0.24V$ http://www.hep.ph.ic.ac.uk/Instrumentation/ 9 November 20, 2001 g.hall@ic.ac.uk

## **Example** - alarm

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# **Oscillators**

## •Basic building block of many systems

clock or timer, signal generators, function generators,...

 $can \ exploit \ positive \ feedback$ 

### •Relaxation oscillator

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charge capacitor C through R ~exp(-t/RC)

v_ crosses threshold at V_{ref}, V_{out} \Rightarrow \pm V_S

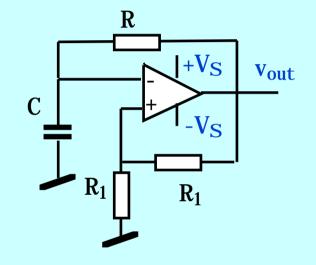
V_{ref} changes sign

etc, etc...

square wave output: [+V_S, -V_S]

Period T = 2.2RC
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•many more types of oscillator design available
IC classic = 555 (many versions)
external components set period and duty cycle
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# Wien bridge oscillator

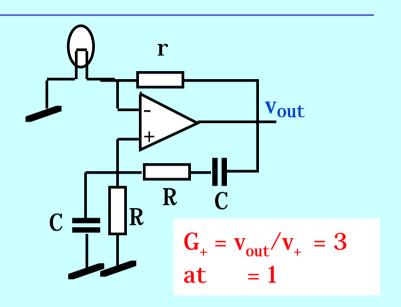
•Sine wave oscillators also often required favourite circuit for audio test applications: low harmonic distortion at f ~ few kHz

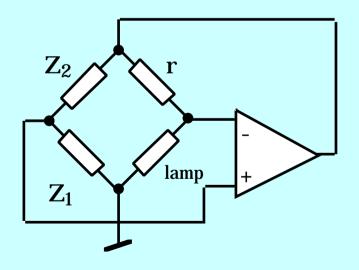
Gain = real at  $_0 = 1/RC$ 

so positive feedback Lamp provides temperature dependent resistor so negative feedback controls amplitude

What values to choose for lamp resistance and r?

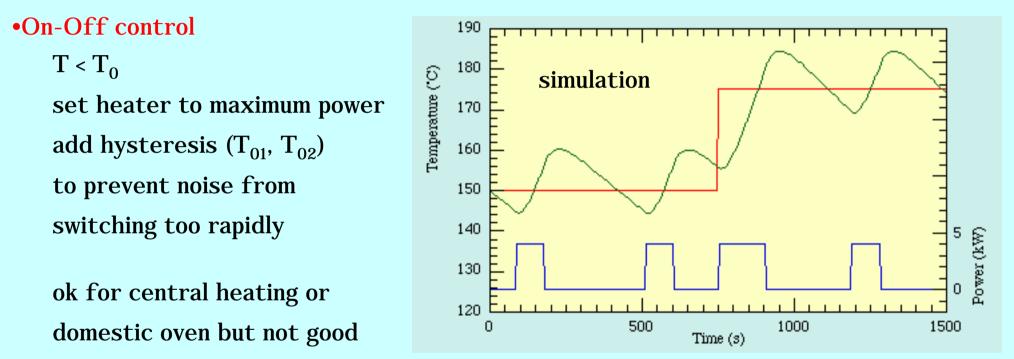
What determines amount of harmonic distortion?





## **Temperature controller**

## •A frequent requirement - similar to many other control applications eg cryostat with stable temperature maintained by resistive heater, or oven, ...



for stable measurements - try to improve

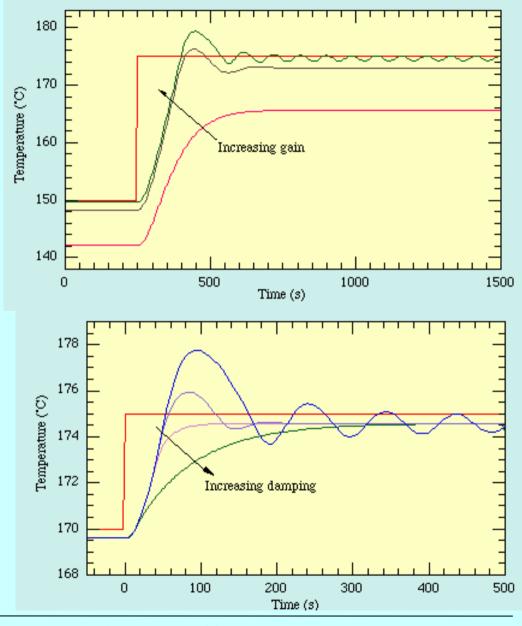
# **P & PD Temperature control**

•Set heater power, proportional to temperature difference (P)

 $W = P(T_{meas}-T_0)$ T still oscillates and undershoots desired value unstable if heat too fast

•Add control term proportional to rate of change (PD) W = P[(T<sub>meas</sub>-T<sub>0</sub>) + Dd(T<sub>meas</sub>-T<sub>0</sub>)/dt]

D too large: overshoot & ringing D too small: slow response



## **PID Temperature control**

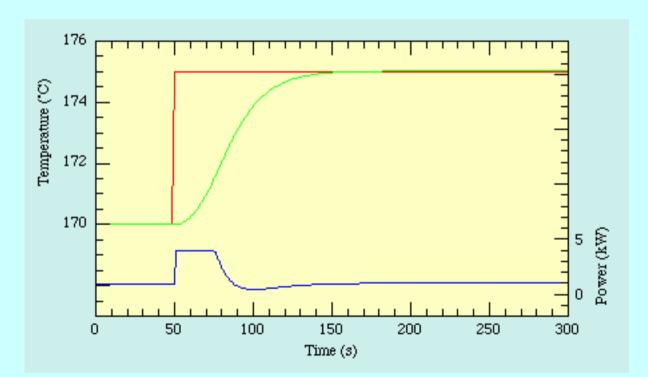
•PD can eliminate ringing & overshoot but undershoot error remains add integral term

•PID control

 $W = P[(T_{meas}-T_0) + Dd(T_{meas}-T_0)/dt + I (T_{meas}-T_0) dt]$ 

good results but need to choose coefficients P, D, I empirically to ensure stability

we'll later look at methods to solve such system equations using transforms

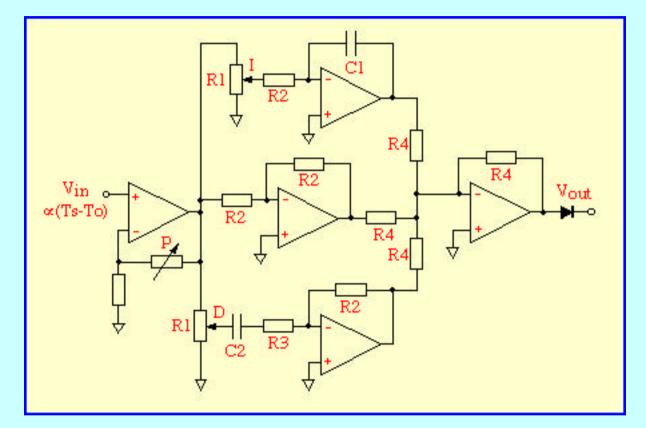


# **Temperature control circuit**

### • Notes

• $R_1 \gg R_2$  to avoid loading •still need heating circuit want W V<sub>out</sub> •Diode ensures W 0 V<sub>diode</sub>?

- •Time constants to be selected depend on appliance chosen commercial devices will recommend values
- •Need to consider offset currents and voltages null, or consider more complex circuit design



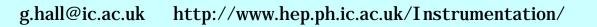
## **Instrumentation amplifier**

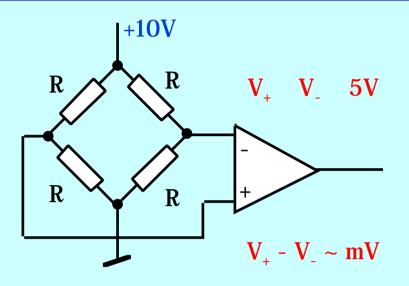
•High gain, dc-coupled differential amplifier single ended output high input impedance high CMRR use to amplify small differential signals where large CM signal may be present but small <u>normal</u> mode eg strain gauge, other bridge circuits

"weak" voltage source

### •Drawback of differential amplifier

relatively low input impedance CMRR relies on excellent resistor matching cheap op-amps may have CMRR ~80dB

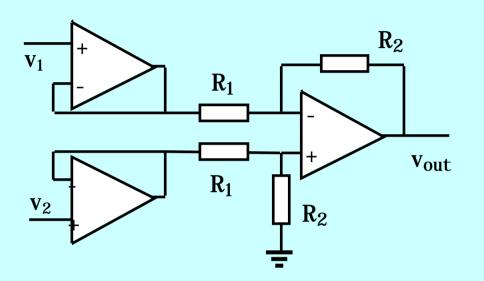




To measure 5mV signal with 1% error CMRR = 0.05/5000 = 100dB

# **Improved differential amplifier**

- •Add voltage buffers and choose precise resistors
  - improves input impedance
  - 0.1% resistors available
  - careful nulling of circuits
  - still need high CMRR from output amplifier big demands on R precision
  - often find restrictions on driving circuit ie source



# **Classic instrumentation amplifier**

### •Input stage differential gain

$$v_{10} - v_1 = iR_2 = v_2 - v_{20} \quad (1)$$
  

$$iR_1 = v_1 - v_2$$
  

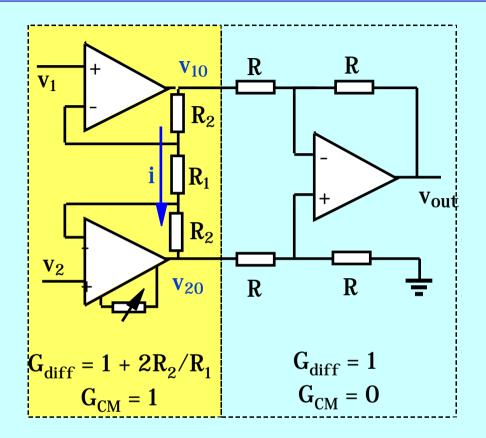
$$(v_{10} - v_{20}) - (v_1 - v_2) = 2iR_2$$
  

$$(v_{10} - v_{20}) = 2iR_2 + iR_1$$
  

$$= (v_1 - v_2)(2R_2 + R_1)/R_1$$
  

$$G_{diff} = 1 + 2R_2/R_1$$

•Input stage common mode gain



Reduce requirements on second stage still choose input amps for good CMRR and null carefully

•Remainder is normal differential amplifier, (G = 1 in this case)

### Instrumentation ICs available

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# **The Instrumentation Amplifier in practice**

•Can add some more useful features

feed common mode level back as guard

connect to cable shield reduce effects of cable capacitance, leakage currents

sense voltage at load

allows feedback to correct for losses in wiring or offset of DC conditions

